Search Notes

Application/Control		Applicant(s)/Patent under Reexamination	
10/567,556	KRYSZ	TOF, ANDRZEJ	
Examiner	Art Unit		
Forrest M. Phillips	2837		

	SEARCHED				
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Class	Subclass	Date	Examiner		
181	131	1/9/2008	FP		
600	528	1/9/2008	FP		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH   (INCLUDING SEAR	NOTES CH STR	ATEGY	)
		DATE	EXMR
EAST 2.1 see atached	1.	/9/2008	FP
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